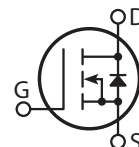
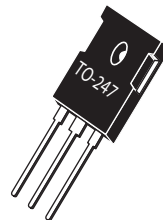


Super Junction MOSFET

- Ultra Low $R_{DS(ON)}$
- Low Miller Capacitance
- Ultra Low Gate Charge, Q_g
- Avalanche Energy Rated
- Extreme dv/dt Rated
- Dual die (parallel)
- Popular T-MAX Package



Unless stated otherwise, Microsemi discrete MOSFETs contain a single MOSFET die. This device is made with two parallel MOSFET die. It is intended for switch-mode operation. It is not suitable for linear mode operation.

MAXIMUM RATINGS

All Ratings per die: $T_C = 25^\circ\text{C}$ unless otherwise specified.

| Symbol | Parameter | APT36N90BC3G | UNIT |
|----------------|--|--------------|------------------|
| V_{DSS} | Drain-Source Voltage | 900 | Volts |
| I_D | Continuous Drain Current @ $T_C = 25^\circ\text{C}$ | 36 | Amps |
| | Continuous Drain Current @ $T_C = 100^\circ\text{C}$ | 23 | |
| I_{DM} | Pulsed Drain Current ¹ | 96 | |
| V_{GS} | Gate-Source Voltage Continuous | ± 20 | Volts |
| P_D | Total Power Dissipation @ $T_C = 25^\circ\text{C}$ | 390 | Watts |
| T_J, T_{STG} | Operating and Storage Junction Temperature Range | -55 to 150 | $^\circ\text{C}$ |
| T_L | Lead Temperature: 0.063" from Case for 10 Sec. | 260 | |
| dv/dt | Drain-Source Voltage slope ($V_{DS} = 400\text{V}$, $I_D = 36\text{A}$, $T_J = 125^\circ\text{C}$) | 50 | V/ns |
| I_{AR} | Avalanche Current ² | 8.8 | Amps |
| E_{AR} | Repetitive Avalanche Energy ² ($I_D = 8.8\text{A}$, $V_{DD} = 50\text{V}$) | 2.9 | mJ |
| E_{AS} | Single Pulse Avalanche Energy ($I_D = 8.8\text{A}$, $V_{DD} = 50\text{V}$) | 1940 | |

STATIC ELECTRICAL CHARACTERISTICS

| Symbol | Characteristic / Test Conditions | MIN | TYP | MAX | UNIT |
|--------------|---|-----|------|------|---------------|
| $BV_{(DSS)}$ | Drain-Source Breakdown Voltage ($V_{GS} = 0\text{V}$, $I_D = 250\mu\text{A}$) | 900 | | | Volts |
| $R_{DS(on)}$ | Drain-Source On-State Resistance ³ ($V_{GS} = 10\text{V}$, $I_D = 18\text{A}$) | | 0.10 | 0.12 | Ohms |
| I_{DSS} | Zero Gate Voltage Drain Current ($V_{DS} = 900\text{V}$, $V_{GS} = 0\text{V}$) | - | - | 100 | μA |
| | Zero Gate Voltage Drain Current ($V_{DS} = 900\text{V}$, $V_{GS} = 0\text{V}$, $T_C = 150^\circ\text{C}$) | - | 50 | - | |
| I_{GSS} | Gate-Source Leakage Current ($V_{GS} = \pm 20\text{V}$, $V_{DS} = 0\text{V}$) | - | - | 100 | nA |
| $V_{GS(th)}$ | Gate Threshold Voltage ($V_{DS} = V_{GS}$, $I_D = 2.9\text{mA}$) | 2.5 | 3 | 3.5 | Volts |

 CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

"COOLMOS™" comprise a new family of transistors developed by Infineon Technologies AG. "COOLMOS" is a trademark of Infineon Technologies AG.

Microsemi Website - <http://www.microsemi.com>

| Symbol | Characteristic | Test Conditions | MIN | TYP | MAX | UNIT |
|--------------|---------------------------------------|--|-----|------|-----|---------|
| C_{iss} | Input Capacitance | $V_{GS} = 0V$ $V_{DS} = 25V$ $f = 1 \text{ MHz}$ | | 7463 | | pF |
| C_{oss} | Output Capacitance | | | 6827 | | |
| C_{rss} | Reverse Transfer Capacitance | | | 167 | | |
| Q_g | Total Gate Charge ⁴ | $V_{GS} = 10V$ $V_{DD} = 450V$ $I_D = 36A @ 25^\circ C$ | | 252 | | nC |
| Q_{gs} | Gate-Source Charge | | | 38 | | |
| Q_{gd} | Gate-Drain ("Miller") Charge | | | 112 | | |
| $t_{d(on)}$ | Turn-on Delay Time | INDUCTIVE SWITCHING $V_{GS} = 15V$ $V_{DD} = 600V$ $I_D = 36A @ 25^\circ C$ $R_G = 4.3\Omega$ | | 70 | | ns |
| t_r | Rise Time | | | 20 | | |
| $t_{d(off)}$ | Turn-off Delay Time | | | 400 | | |
| t_f | Fall Time | | | 25 | | |
| E_{on} | Turn-on Switching Energy ⁵ | INDUCTIVE SWITCHING @ 25°C $V_{DD} = 600V, V_{GS} = 15V$ $I_D = 36A, R_G = 4.3\Omega$ | | 1500 | | μJ |
| E_{off} | Turn-off Switching Energy | | | 750 | | |
| E_{on} | Turn-on Switching Energy ⁵ | INDUCTIVE SWITCHING @ 125°C $V_{DD} = 600V, V_{GS} = 15V$ $I_D = 36A, R_G = 4.3\Omega$ | | 2130 | | |
| E_{off} | Turn-off Switching Energy | | | 867 | | |

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

| Symbol | Characteristic / Test Conditions | MIN | TYP | MAX | UNIT |
|-----------|---|---------------------|------|-----|---------|
| I_S | Continuous Source Current (Body Diode) | | 36 | | Amps |
| I_{SM} | Pulsed Source Current ¹ (Body Diode) | | 96 | | Amps |
| V_{SD} | Diode Forward Voltage ³ ($V_{GS} = 0V, I_S = 18A$) | | 0.8 | 1.2 | Volts |
| dv/dt | Peak Diode Recovery dv/dt ⁶ | | | 10 | V/ns |
| t_{rr} | Reverse Recovery Time ($I_S = -36A, di/dt = 100A/\mu s$) | $T_J = 25^\circ C$ | 930 | | ns |
| | | $T_J = 125^\circ C$ | 1230 | | |
| Q_{rr} | Reverse Recovery Charge ($I_S = -36A, di/dt = 100A/\mu s$) | $T_J = 25^\circ C$ | 35 | | μC |
| | | $T_J = 125^\circ C$ | 44 | | |
| I_{RRM} | Peak Recovery Current ($I_S = -36A, di/dt = 100A/\mu s$) | $T_J = 25^\circ C$ | 70 | | Amps |
| | | $T_J = 125^\circ C$ | 68 | | |

THERMAL CHARACTERISTICS

| Symbol | Characteristic | MIN | TYP | MAX | UNIT |
|-----------------|---------------------|-----|-----|-----|--------------|
| $R_{\theta JC}$ | Junction to Case | | | 0.3 | $^\circ C/W$ |
| $R_{\theta JA}$ | Junction to Ambient | | | 31 | |

1 Repetitive Rating: Pulse width limited by maximum junction temperature

2 Repetitive avalanche causes additional power losses that can be calculated as $P_{AV} = E_{AR} \cdot f$. Pulse width tp limited by T_J max.

3 Pulse Test: Pulse width < 380 μs , Duty Cycle < 2%

4 See MIL-STD-750 Method 3471

5 E_{on} includes diode reverse recovery.

6 Maximum 125°C diode commutation speed = di/dt 600A/ μs

Microsemi reserves the right to change, without notice, the specifications and information contained herein.

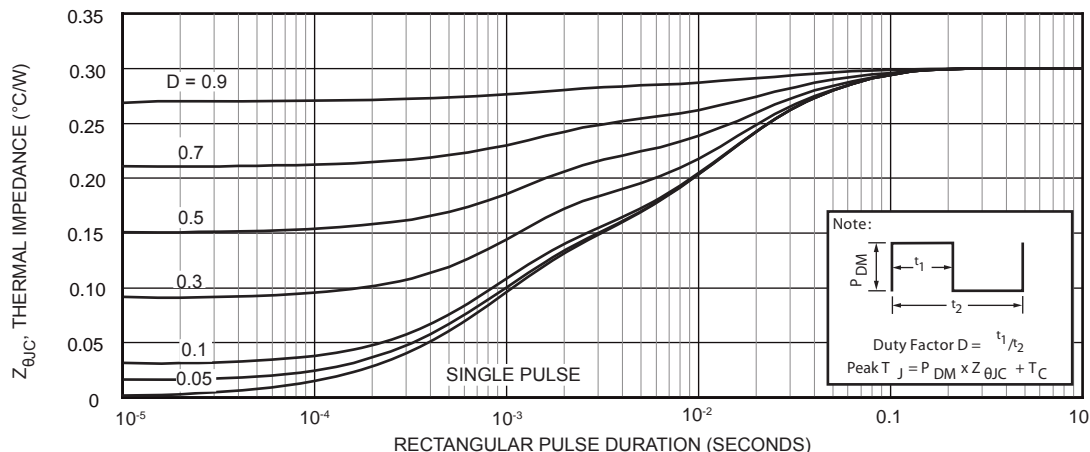


Figure 1, Maximum Effective Transient Thermal Impedance, Junction-To-Case vs Pulse Duration

Typical Performance Curves

APT36N90BC3G

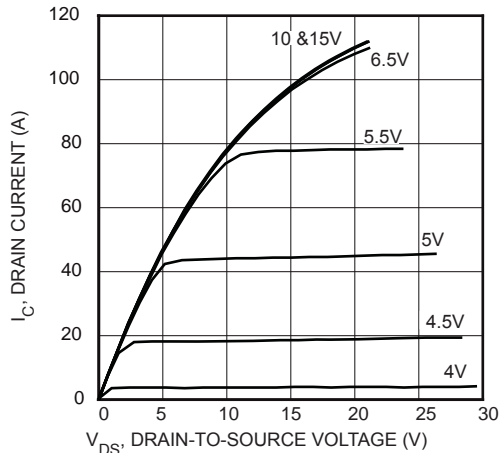


FIGURE 2, Low Voltage Output Characteristics

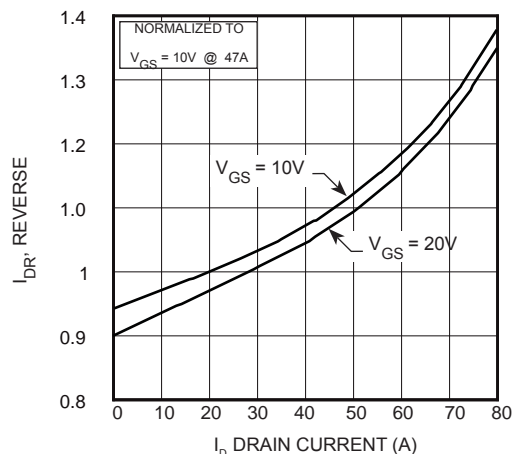


FIGURE 4, $R_{DS(ON)}$ vs Drain Current

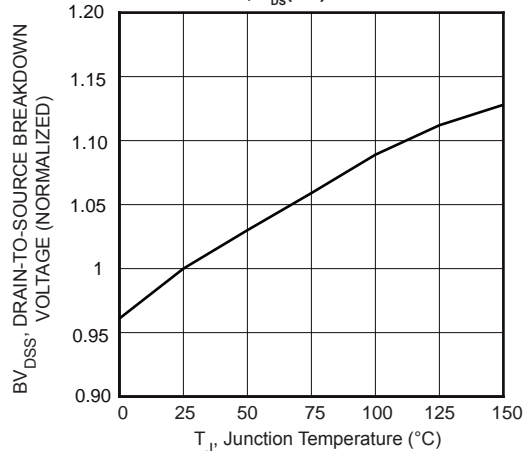


FIGURE 6, Breakdown Voltage vs Temperature

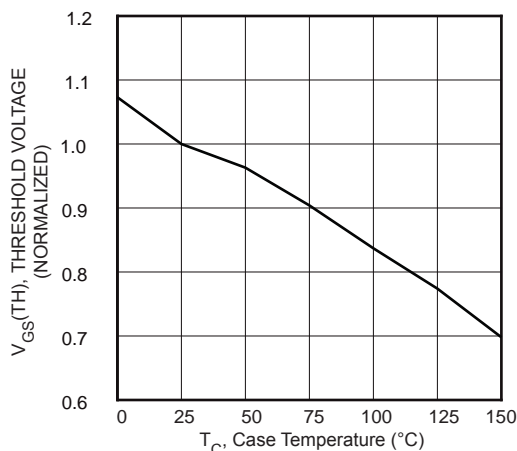


FIGURE 8, Threshold Voltage vs Temperature

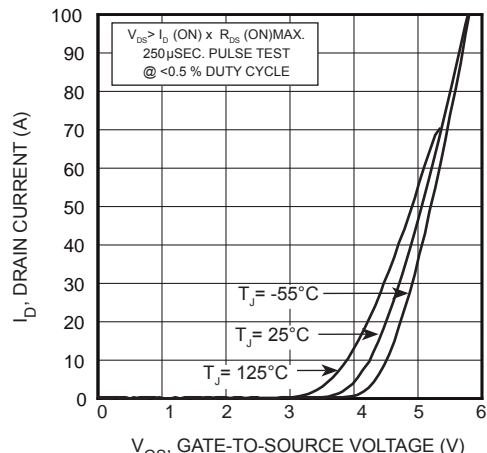


FIGURE 3, Transfer Characteristics

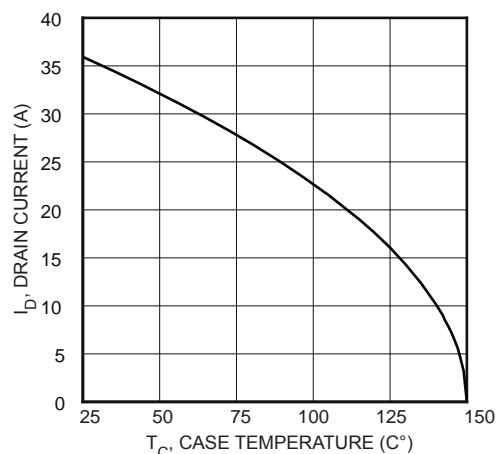


FIGURE 5, Maximum Drain Current vs Case Temperature

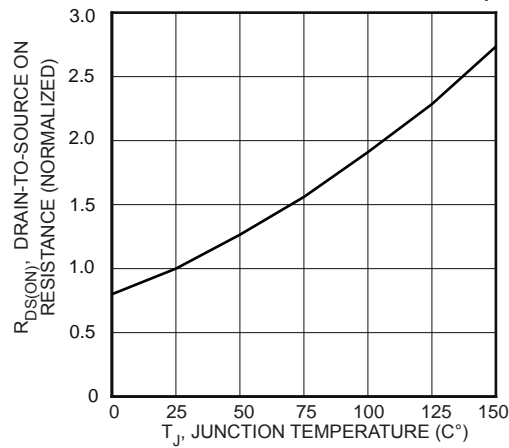


FIGURE 7, On-Resistance vs Temperature

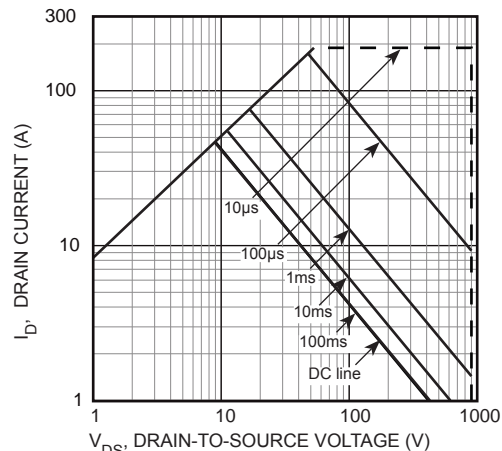


FIGURE 9, Maximum Safe Operating Area

Typical Performance Curves

APT36N90BC3G

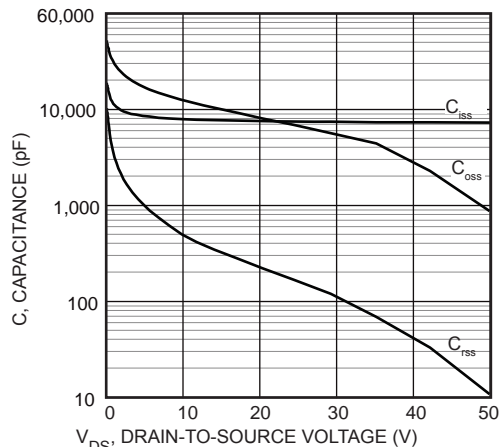


FIGURE 10, Capacitance vs Drain-To-Source Voltage

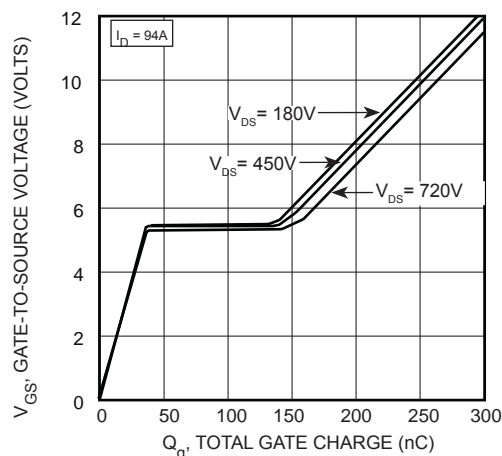


FIGURE 11, Gate Charges vs Gate-To-Source Voltage

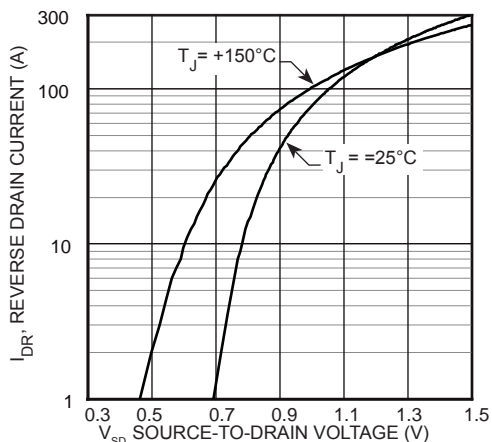


FIGURE 12, Source-Drain Diode Forward Voltage

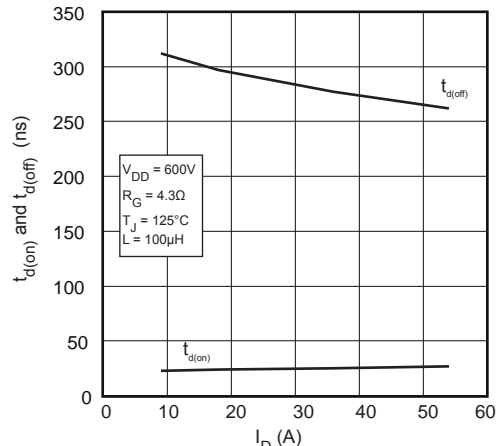


FIGURE 13, Delay Times vs Current

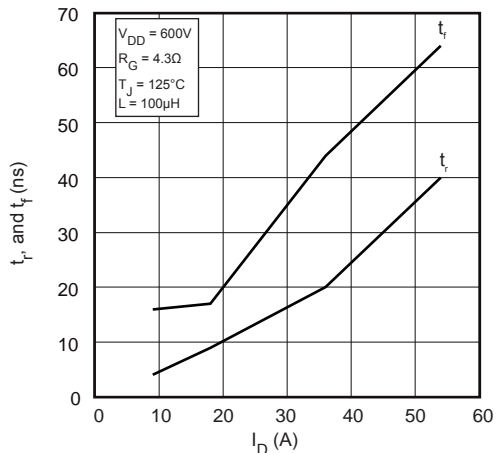


FIGURE 14, Rise and Fall Times vs Current

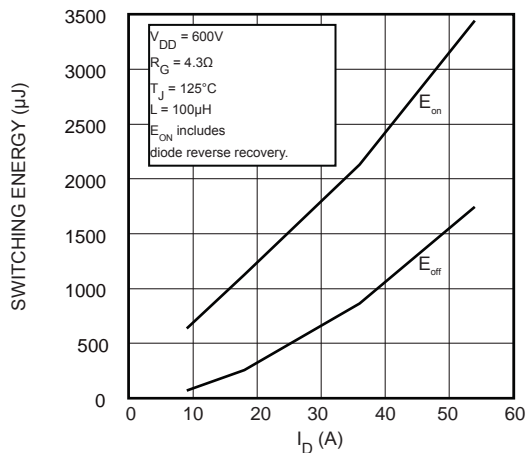


FIGURE 15, Switching Energy vs Current

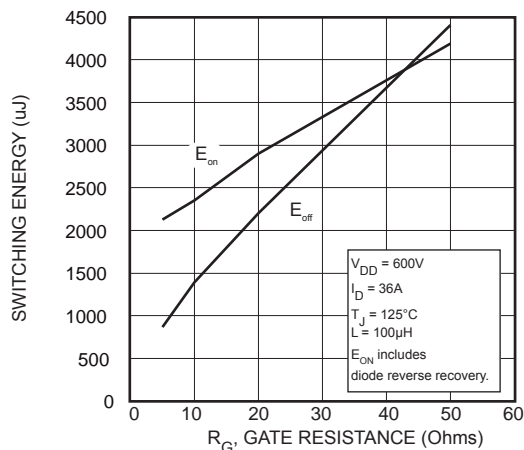


FIGURE 16, Switching Energy vs Gate Resistance

Typical Performance Curves

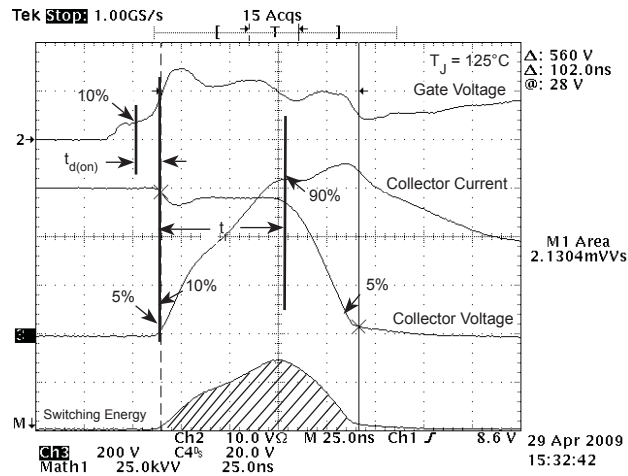


Figure 17, Turn-on Switching Waveforms and Definitions

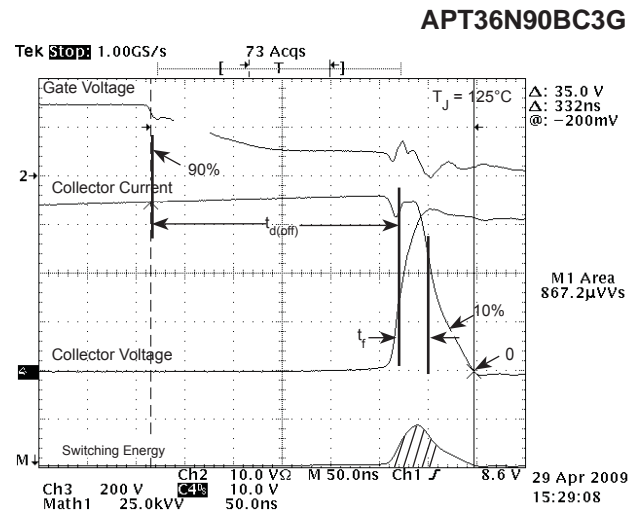


Figure 18, Turn-off Switching Waveforms and Definitions

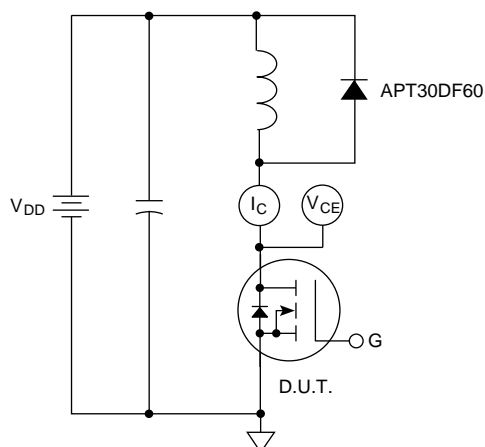
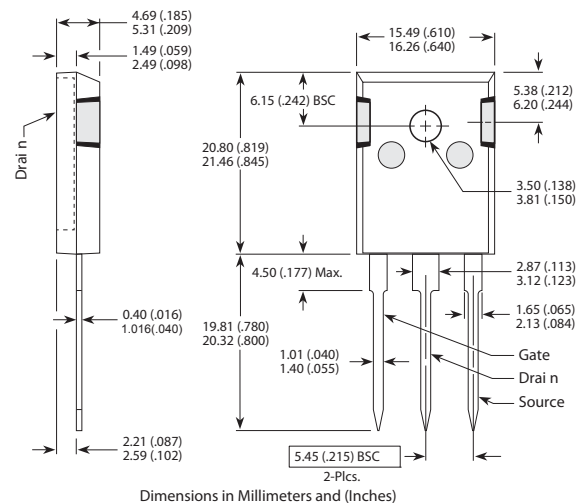


Figure 19, Inductive Switching Test Circuit

TO-247[®] Package Outline



Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

[Microchip:](#)

[APT36GA60BD15](#)